## Notice of References Cited Application/Control No. 10/617,565 Examiner Anthony Weier Applicant(s)/Patent Under Reexamination NIE ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,523,293	06-1996	Jane et al.	514/21
*	В	US-2003/0219516	11-2003	Pater et al.	426/132
*	С	US-6,159,516	12-2000	Axelrod et al.	426/456
*	D	US-2004/0170732	09-2004	Axelrod et al.	426/516
*	Ε	US-6,277,420	08-2001	Andersen et al.	426/92
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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